Preferred Device

Silicon Controlled Rectifiers

Reverse Blocking Thyristors

Designed primarily for half-wave ac control applications, such as motor controls, heating controls and power supplies; or wherever half-wave silicon gate-controlled, solid-state devices are needed.

- Glass Passivated Junctions with Center Gate Geometry for Greater Parameter Uniformity and Stability
- Small, Rugged, Thermowatt Construction for Low Thermal Resistance, High Heat Dissipation and Durability
- Blocking Voltage to 800 Volts
- Device Marking: Logo, Device Type, e.g., 2N6400, Date Code

*MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit |
|---|--|---------------------------------------|------------------|
| Peak Repetitive Off–State Voltage (Note 1.) $(T_J = -40 \text{ to } 125^{\circ}\text{C}, \text{ Sine Wave} \\ 50 \text{ to } 60 \text{ Hz; Gate Open}) \\ 2N6400 \\ 2N6401 \\ 2N6402 \\ 2N6403 \\ 2N6404 \\ 2N6405$ | V _{DRM} , V _{RRM} | 50 100 200 400 600 800 | Volts |
| On-State RMS Current (180° Conduction Angles; T _C = 100°C) | I _{T(RMS)} | 16 | А |
| Average On-State Current (180° Conduction Angles; T _C = 100°C) | I _{T(AV)} | 10 | А |
| Peak Non-repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T _J = 90°C) | I _{TSM} | 160 | А |
| Circuit Fusing (t = 8.3 ms) | l ² t | 145 | A ² s |
| Forward Peak Gate Power (Pulse Width ≤ 1.0 μs, T _C = 100°C) | P _{GM} | 20 | Watts |
| Forward Average Gate Power (t = 8.3 ms, T _C = 100°C) | P _{G(AV)} | 0.5 | Watts |
| Forward Peak Gate Current (Pulse Width ≤ 1.0 µs, T _C = 100°C) | I _{GM} | 2.0 | А |
| Operating Junction Temperature Range | TJ | -40 to +125 | °C |
| Storage Temperature Range | T _{stg} | -40 to +150 | °C |

^{*}Indicates JEDEC Registered Data.

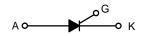
 V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.



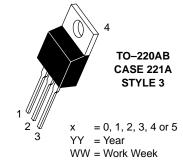
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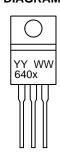
http://onsemi.com

SCRs 16 AMPERES RMS 50 thru 800 VOLTS



MARKING DIAGRAM





| PIN ASSIGNMENT | | | |
|----------------|---------|--|--|
| 1 | Cathode | | |
| 2 | Anode | | |
| 3 | Gate | | |
| 4 | Anode | | |

ORDERING INFORMATION

| Davisa | Daalaana | Chinnina |
|--------|----------|----------|
| Device | Package | Shipping |
| 2N6400 | TO220AB | 500/Box |
| 2N6401 | TO220AB | 500/Box |
| 2N6402 | TO220AB | 500/Box |
| 2N6403 | TO220AB | 500/Box |
| 2N6404 | TO220AB | 500/Box |
| 2N6405 | TO220AB | 500/Box |

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS

| Characteristic | | Max | Unit |
|---|-----------------|-----|------|
| Thermal Resistance, Junction to Case | $R_{\theta JC}$ | 1.5 | °C/W |
| Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds | TL | 260 | °C |

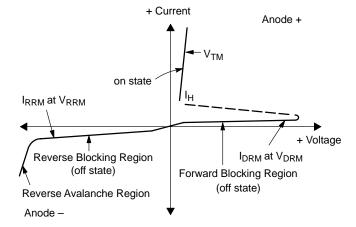
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted.)

| Characteristic | | Symbol | Min | Тур | Max | Unit |
|--|--|-------------------------------------|--------|----------|-------------|----------|
| OFF CHARACTERISTICS | | | • | | | |
| *Peak Repetitive Forward or Reverse Blocking C $(V_{AK} = Rated V_{DRM} \text{ or } V_{RRM}, \text{ Gate Open})$ | Furrent $T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$ | I _{DRM} , I _{RRM} | _ _ | _ _ | 10 2.0 | μA mA |
| ON CHARACTERISTICS | | | | | | |
| *Peak Forward On–State Voltage (I _{TM} = 32 A Peak, Pulse Width ≤ 1 ms, Duty C | ycle ≤ 2%) | V _{TM} | _ | _ | 1.7 | Volts |
| *Gate Trigger Current (Continuous dc) (V _D = 12 Vdc, R _L = 100 Ohms) | $T_C = 25^{\circ}C$ $T_C = -40^{\circ}C$ | I _{GT} | - | 9.0 - | 30 60 | mA |
| *Gate Trigger Voltage (Continuous dc) (V _D = 12 Vdc, R _L = 100 Ohms) | $T_C = 25^{\circ}C$ $T_C = -40^{\circ}C$ | V _{GT} | _ _ | 0.7 - | 1.5 2.5 | Volts |
| Gate Non-Trigger Voltage (V _D = 12 Vdc, R _L = 100 Ohms) | T _C = +125°C | V_{GD} | 0.2 | - | _ | Volts |
| *Holding Current (V _D = 12 Vdc, Initiating Current = 200 mA, Gate Open) | $T_C = 25^{\circ}C$ $*T_C = -40^{\circ}C$ | lн | - | 18 _ | 40 60 | mA |
| Turn-On Time (I _{TM} = 16 A, I _{GT} = 40 mAdc, V_D = Rated V_{DRM} |) | t _{gt} | - | 1.0 | - | μs |
| Turn-Off Time ($I_{TM} = 16 \text{ A}, I_R = 16 \text{ A}, V_D = \text{Rated } V_{DRM}$) | T _C = 25°C T _J = +125°C | tq | _ _ | 15 35 | _ _ _ | μs |
| DYNAMIC CHARACTERISTICS | | | | | | |
| Critical Rate-of-Rise of Off-State Voltage $(V_D = Rated V_{DRM}, Exponential Waveform)$ | T _J = +125°C | dv/dt | _ | 50 | - | V/μs |

^{*}Indicates JEDEC Registered Data.

Voltage Current Characteristic of SCR

| Symbol | Parameter |
|------------------|---|
| V _{DRM} | Peak Repetitive Off State Forward Voltage |
| I _{DRM} | Peak Forward Blocking Current |
| V _{RRM} | Peak Repetitive Off State Reverse Voltage |
| I _{RRM} | Peak Reverse Blocking Current |
| V_{TM} | Peak On State Voltage |
| IH | Holding Current |



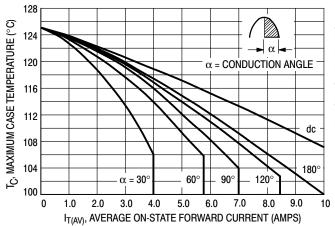


Figure 1. Average Current Derating

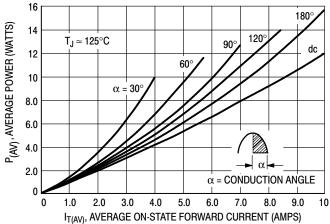


Figure 2. Maximum On-State Power Dissipation

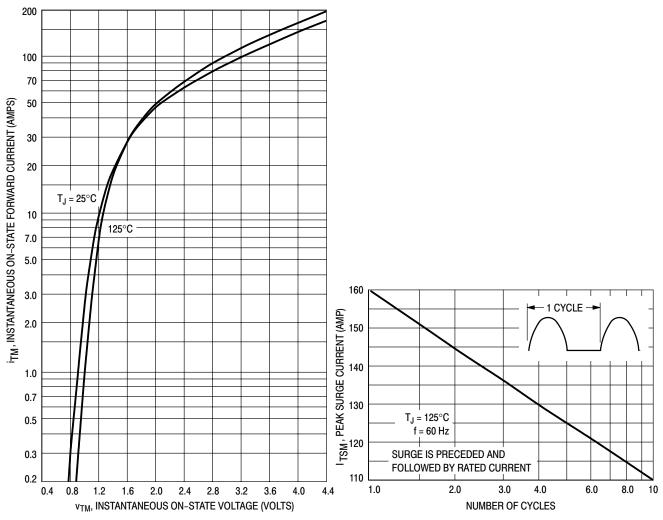


Figure 3. On-State Characteristics

Figure 4. Maximum Non-Repetitive Surge Current

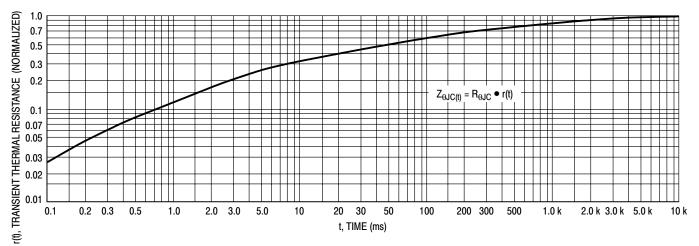


Figure 5. Thermal Response

TYPICAL CHARACTERISTICS

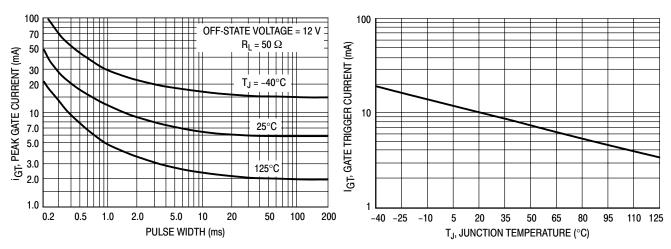


Figure 6. Typical Gate Trigger Current versus Pulse Width

Figure 7. Typical Gate Trigger Current versus Junction Temperature

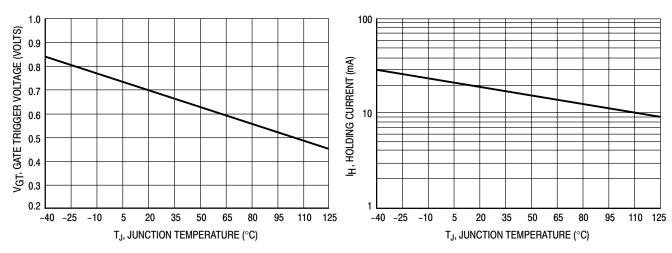
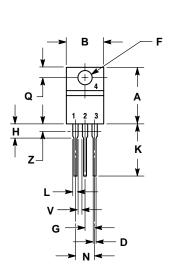


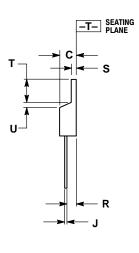
Figure 8. Typical Gate Trigger Voltage versus Junction Temperature

Figure 9. Typical Holding Current versus Junction Temperature

PACKAGE DIMENSIONS

TO-220AB CASE 221A-07 **ISSUE AA**





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

| | INCHES | | MILLIN | IETERS |
|-----|--------|-------|--------|--------|
| DIM | MIN | MAX | MIN | MAX |
| Α | 0.570 | 0.620 | 14.48 | 15.75 |
| В | 0.380 | 0.405 | 9.66 | 10.28 |
| С | 0.160 | 0.190 | 4.07 | 4.82 |
| D | 0.025 | 0.035 | 0.64 | 0.88 |
| F | 0.142 | 0.147 | 3.61 | 3.73 |
| G | 0.095 | 0.105 | 2.42 | 2.66 |
| Н | 0.110 | 0.155 | 2.80 | 3.93 |
| J | 0.014 | 0.022 | 0.36 | 0.55 |
| K | 0.500 | 0.562 | 12.70 | 14.27 |
| L | 0.045 | 0.060 | 1.15 | 1.52 |
| N | 0.190 | 0.210 | 4.83 | 5.33 |
| Q | 0.100 | 0.120 | 2.54 | 3.04 |
| R | 0.080 | 0.110 | 2.04 | 2.79 |
| S | 0.045 | 0.055 | 1.15 | 1.39 |
| Т | 0.235 | 0.255 | 5.97 | 6.47 |
| U | 0.000 | 0.050 | 0.00 | 1.27 |
| ٧ | 0.045 | | 1.15 | |
| Z | | 0.080 | | 2.04 |

- STYLE 3:
 PIN 1. CATHODE
 2. ANODE
 3. GATE
 4. ANODE



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